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PATENT AND TRADEMARK OFFICE  LIST OF REFERENCES CITED BY APPLICANT(S)  (Use several sheets if necessary)  Date Submitted to PTO: June 14, 2002				APPLICANT Hisashi ISAKA					-
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				U.S. PATENT DOCUMEN	TS				
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CL	CLASS SUBCLASS FILING DATE II APPROPRIATE			
PS	AA	4,311,782	1/1982	Buhr et al.	8	,,			
(PS	AB	5,824,343	10/1998	Ng et al.					
PS	AC	4,368,314	1/1983	Endo et al.			Dr		
PS	AD	5,932,747	8/1999	Bauer et al.			REC JUN	EIVE	`A-
	AE		MAIC				JUN	8 2000	U
	AF	JUN	1 4 2000 0				TECH CENTE	9 160000	<del></del>
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		-		FOREIGN PATENT DOCUM	ENTS			, a seem	
	-	DOCUMENT NUMBER	DATE	COUNTRY	Cı	ASS	SUBCLASS	TRANSI YES	
62	AJ	60-233114	11/1985	Japan	·			Abstract	
13	AĶ	97/31073 D	8/1997	РСТ					
PS	AL	91/03510 i	3/1991	PCT					
PS	AM	0 866 065	9/1998	Europe					×
R5	AN	2000-144040	5/2000	Japan			,	Abstract	
	<del></del>	ОТН	ER DOCUMENT(S	S) (Including Author, Title,	Date, Pertinent Pa	ges, Etc.,	<u> </u>		
PS	AO	Narain et al., In	dian J. Chem.	, Vol 17B, pp. 189-1	91 (1979)		·		
	AP	-			•	0	120	-	. *:.
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5VA 14115	10	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \			CONCIDENT	·	121/04		
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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Rec'd PCT/PTO 1 8 MAR 2002 Sheet 1 of 1 SERIAL NO. ATTY DOCKET NO. FORM PTO 1449 (modified) [NEW] 2002-0382A U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE APPLICANT Hisashi ISAKA et al. LIST OF REFERENCES CITED BY APPLICANTIS) (Use several sheets if necessary) GROUP FILING DATE March 18, 2002 Date Submitted to PTO: Merch 18, 2002 U.S. PATENT DOCUMENTS SUBCLASS FILING DATE IF DOCUMENT DATE NAME CLASS \*EXAMINER INITIAL APPROPRIATE NUMBER AA ΑB AC AD ΑE AF AG AH ΑI FOREIGN PATENT DOCUMENTS CLASS SUBCLASS TRANSLATION DOCUMENT NUMBER COUNTRY DATE YES PCT 3/1991 ΑJ 91/03510 4 866,065 9/1998 Europe AK 2000-144040 AL 5/2000 Japan AM ΑN OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.) Narain et al., Indian J. Chem., 17B, pp. 189-191 (1979) ΑQ PS AP

DATE CONSIDERED

64

21

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**EXAMINER** 

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.